

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/630,435	KRULL, MARK A.
	<b>Examiner</b>	Art Unit
	Kien T. Nguyen	3714

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner